Search Notes				

Application/Control No.	Applicant(s)/Patent Reexamination
10/709.728	HSIEH ET AL.

Examiner

Gene L. Bankhead

Applicant(s)/Patent under
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SEARCHED				
Class	Subclass	Date	Examiner	
62	126	11/21/2006	GB	
	129	11/21/2006	GB	
	207	11/21/2006	GB	
	208	11/21/2006	GB	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH	STRATEGY)	
	DATE	EXMR
Consulted with Primary Examiner Marc Norman	11/20/2006	GB
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